

#4

Sheet 1 of 1

Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DKT. NO. 843.41042X00	SERIAL NO. 10/025,457
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		APPLICANT HAYANO, et al.	
		FILING DATE December 26, 2001	GROUP 1756

U.S. PATENT DOCUMENTS

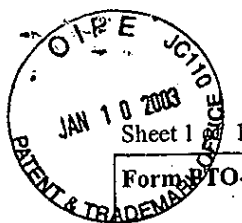
Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
	AA					
	AB					
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FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation /Abstract	
						Yes	No
SPW	AM 2000-17196	1-18-00	Japan			X	
	AN						
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

SPW	AU	Nikkei Microdevices, April 2000, p. 145, 146.
SPW	AV	Nikkei Microdevices, May 2000, p. 143-152.
SPW	AW	Optical Microlithography XIII 1-3, March 2000, p. 647-657.
	AX	
	AY	
	AZ	
Examiner Mohamedolla		Date Considered 12/15/03



#5

Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DKT. NO. 843.41042X00	SERIAL NO. 10/025,457
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U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
	AA					
	AB					
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	AI					
	AJ					
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	AL					

FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation / Abstract	
						Yes	No
SP	AM 56-30129	3/26/1981	Japan			X	
SP	AN 59-22050	2/4/1984	Japan			X	
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner	AU	
	AV	
	AW	
	AX	
	AY	
	AZ	
Mohamedolla	Date Considered	12/15/03

GROUP
IBD 17.56

12/15/03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.